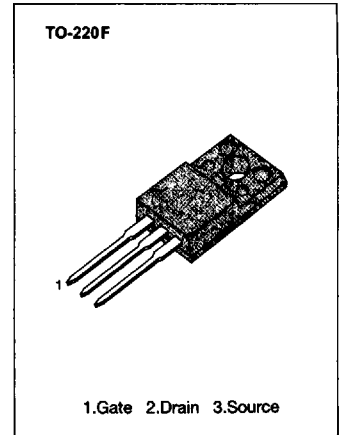


## FEATURES

- Lower  $R_{DS(on)}$
- Improved inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Lower input capacitance
- Extended safe operating area
- Improved high temperature reliability

## PRODUCT SUMMARY

Part Number	$BV_{DSS}$	$R_{DS(on)}$	$I_D$
SSS5N90	900V	2.5 $\Omega$	2.8A



## ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	SSS5N90	Unit
Drain-Source Voltage (1)	$V_{DSS}$	900	Vdc
Drain-Gate Voltage ( $R_{GS}=1.0M\Omega$ )	$V_{DGR}$	900	Vdc
Gate-Source Voltage	$V_{GS}$	$\pm 30$	Vdc
Continuous Drain Current $T_C=25^\circ C$	$I_D$	2.8	Adc
Continuous Drain Current $T_C=100^\circ C$	$I_D$	2.0	Adc
Drain Current - Pulsed (3)	$I_{DM}$	20	Adc
Single Pulsed Avalanche Energy (4)	EAS	241	mJ
Avalanche Current	$I_{AS}$	2.8	A
Total Power Dissipation at $T_C=25^\circ C$	$P_D$	43	Watts
Derate above $25^\circ C$		0.34	W/ $^\circ C$
Operating and Storage Junction Temperature Range	$T_J, T_{STG}$	-55 to +150	$^\circ C$
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	$T_L$	300	$^\circ C$

Notes : (1)  $T_J=25^\circ C$  to  $150^\circ C$

(2) Pulse test : Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

(3) Repetitive rating : Pulse width limited by max. junction temperature

(4)  $L=51mH$ ,  $V_{dd}=50V$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ C$

**ELECTRICAL CHARACTERISTICS** (Tc=25°C unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	900	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	-	4.5	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
I <sub>GSS</sub>	Gate-Source Leakage Forward	-	-	100	nA	V <sub>GS</sub> =20V
I <sub>GSS</sub>	Gate-Source Leakage Reverse	-	-	-100	nA	V <sub>GS</sub> =-20V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	-	-	250	μA	V <sub>DS</sub> =Max. Rating, V <sub>GS</sub> =0V
		-	-	1000		V <sub>DS</sub> =0.8 Max. Rating, V <sub>GS</sub> =0V, Tc=150°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance(2)	-	1.7	2.5	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =2.5A
g <sub>fs</sub>	Forward Transconductance (2)	3.5	-	-	U	V <sub>DS</sub> =15V, I <sub>D</sub> =2.5A
C <sub>iss</sub>	Input Capacitance	-	1700	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz
C <sub>oss</sub>	Output Capacitance	-	140	-	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	-	60	-	pF	
t <sub>d(on)</sub>	Turn-On Delay Time	-	40	-	ns	V <sub>DD</sub> =0.5 BV <sub>DSS</sub> , I <sub>D</sub> =5.0A, Z <sub>θ</sub> =9.1Ω (MOSFET switching times are essentially independent of operating temperature)
t <sub>r</sub>	Rise Time	-	90	-	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	-	250	-	ns	
t <sub>f</sub>	Fall Time	-	100	-	ns	
Q <sub>g</sub>	Total Gate Charge (Gate-Source Plus Gate-Drain)	-	-	110	nC	V <sub>GS</sub> =10V, I <sub>D</sub> =5.0A, V <sub>DS</sub> =0.8 Max. Rating (Gate charge is essentially independent of operating temperature)
Q <sub>gs</sub>	Gate-Source Charge	-	13	-	nC	
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	-	40	-	nC	

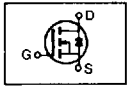
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**THERMAL RESISTANCE**

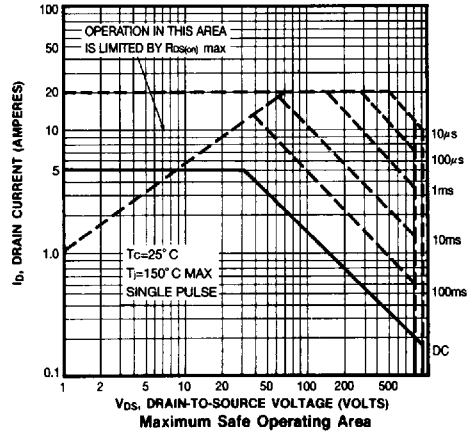
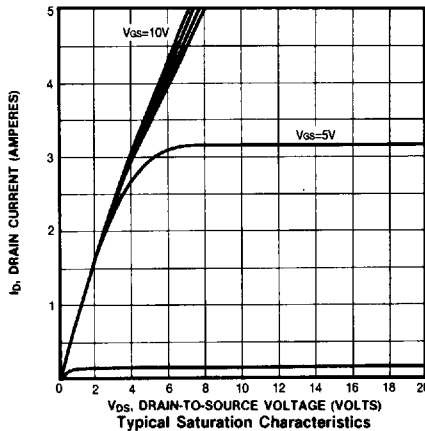
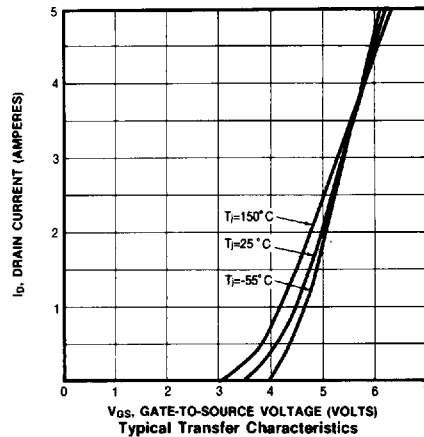
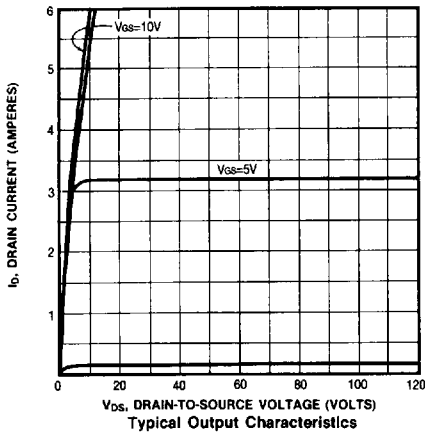
Symbol	Characteristics		SSS5N90	Units	Remark
R <sub>thJC</sub>	Junction-to-Case	MAX	2.90	K/W	
R <sub>thCS</sub>	Case-to-Sink	TYP	0.5	K/W	Mounting surface flat
R <sub>thJA</sub>	Junction-to-Ambient	MAX	62.5	K/W	Free Air Operation

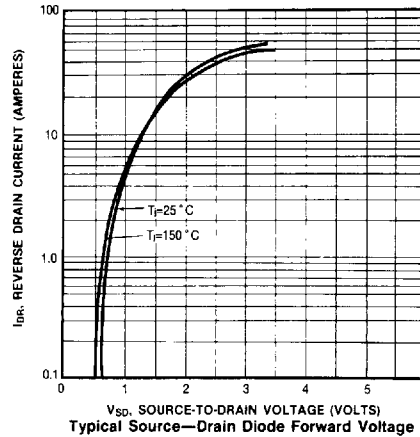
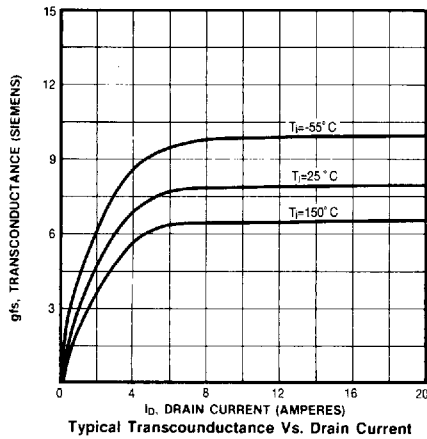
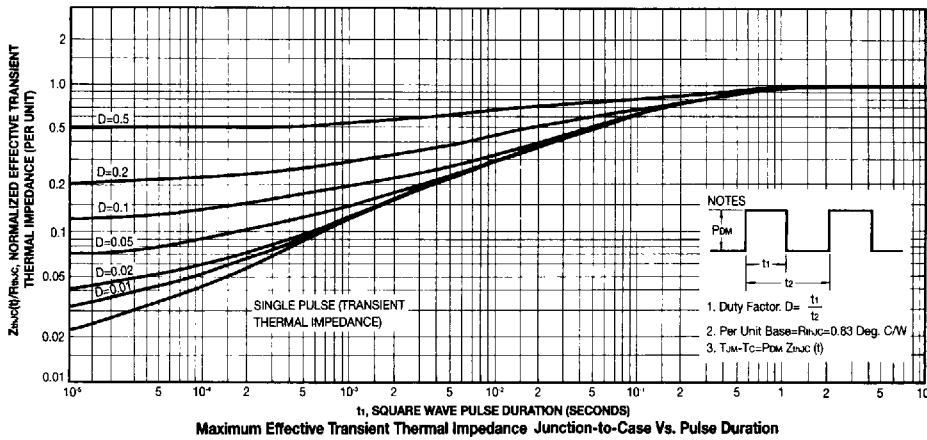
- Notes : (1) T<sub>J</sub>=25°C to 150°C  
 (2) Pulse test : Pulse width ≤ 300μs, Duty Cycle ≤ 2%  
 (3) Repetitive rating : Pulse width limited by max. junction temperature

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	-	-	5.0	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier 
$I_{SM}$	Pulse Source Current (Body Diode) (3)	-	-	20.0	A	
$V_{SD}$	Diode Forward Voltage (2)	-	-	1.5	V	$T_J=25^\circ\text{C}$ , $I_S=5.0\text{A}$ , $V_{GS}=0\text{V}$
$t_r$	Reverse Recovery Time	-	500	-	ns	$T_J=150^\circ\text{C}$ , $I_F=5.0\text{A}$ , $dI_F/dt=100\text{A}/\mu\text{s}$

- Notes : (1)  $T_J=25^\circ\text{C}$  to  $150^\circ\text{C}$   
 (2) Pulse test : Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$   
 (3) Repetitive rating : Pulse width limited by max. junction temperature





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